

Hex Buffer With Open-Drain Outputs

1. Description

The 74LVC07 provides six non-inverting buffers. The outputs are open-drain and can be connected to other open-drain outputs to implement active-LOW wired-OR or active-HIGH wired-AND functions. Inputs can be driven from either 3.3V or 5V devices. This feature allows the use of these devices as translators in mixed 3.3V and 5V applications.

2. Features

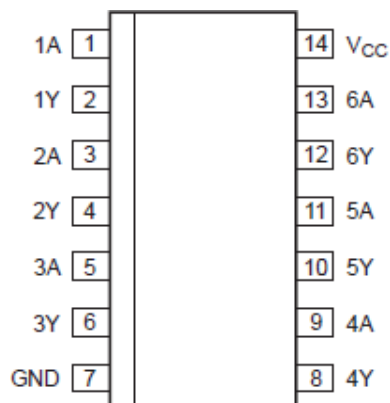
- 5V tolerant inputs and outputs (open-drain) for interfacing with 5V logic
- Wide supply voltage range from 1.2V to 5.5V
- CMOS low power consumption
- Direct interface with TTL levels
- Inputs accept voltages up to 5V
- Specified from -40°C to +105°C
- Packaging information:
DIP14/SOIC14/TSSOP14

3. Ordering Information

Type Number	Package Type	Packing	Notes
74LVC07AN	DIP-14	Tube	
74LVC07AD	SOIC-14	Tape & Reel	
74LVC07APW	TSSOP-14	Tape & Reel	

Note: If the physical information is inconsistent with the ordering information, please refer to the actual product.

4. Pin Configurations



Pin Description

Pin No.	Pin Name	Description
1	1A	data input
2	1Y	data output
3	2A	data input
4	2Y	data output
5	3A	data input
6	3Y	data output
7	GND	ground (0V)
8	4Y	data output
9	4A	data input
10	5Y	data output
11	5A	data input
12	6Y	data output
13	6A	data input
14	V _{CC}	supply voltage

Function Table

Input	Output
nA	nY
L	L
H	Z

Note: H=HIGH voltage level; L=LOW voltage level; Z=high-impedance OFF-state.

5. Block Diagram

Block Diagram

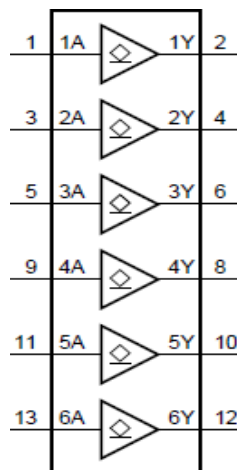
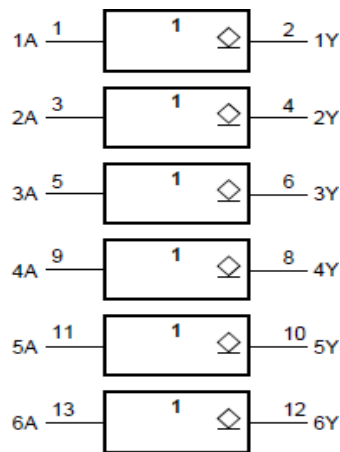
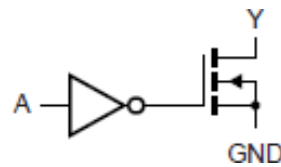


Fig. 1. Logic symbol


Fig. 2. IEC logic symbol

Fig. 3. Logic diagram for one gate

6. Electrical Parameter

Absolute Maximum Ratings

(Voltages are referenced to GND (ground=0V), unless otherwise specified.)

Parameter	Symbol	Conditions	Min.	Max.	Unit
supply voltage	V_{CC}	-	-0.5	+6.5	V
input clamping current	I_{IK}	$V_I < 0V$	-50	-	mA
input voltage	V_I	-	-0.5	+6.5	V
output clamping current	I_{OK}	$V_O < 0V$	-50	-	mA
output voltage	V_O	active mode	-0.5	+6.5	V
		high-impedance mode	-0.5	+6.5	V
output current	I_O	$V_O = 0V$ to V_{CC}	-	50	mA
supply current	I_{CC}	-	-	100	mA
ground current	I_{GND}	-	-100	-	mA
total power dissipation	P_{tot}	-	-	500	mW
storage temperature	T_{stg}	-	-65	+150	°C
Soldering temperature	T_L	10s	DIP	245	°C
			SOIC	250	

Note:

- 1 For DIP14 packages: above 70°C the value of P_{tot} derates linearly with 12mW/K.
- 2 For SOIC14 packages: above 70°C the value of P_{tot} derates linearly with 8mW/K.
- 3 For TSSOP14 packages: above 60°C the value of P_{tot} derates linearly with 5.5mW/K.

Recommended Operating Conditions

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
supply voltage	V _{CC}	-	1.65	-	5.5	V
		functional	1.2	-	-	V
input voltage	V _I	-	0	-	5.5	V
output voltage	V _O	active mode	0	-	V _{CC}	V
		high-impedance mode	0	-	5.5	V
ambient temperature	T _{amb}	-	-40	-	+105	°C
input transition rise and fall rate	Δt/ΔV	V _{CC} =1.65V to 2.7V	0	-	20	ns/V
		V _{CC} =2.7V to 3.6V	0	-	10	ns/V

7. Electrical Characteristics

DC Characteristics 1

(T_{amb}=-40°C to +85°C, voltages are referenced to GND (ground=0V), unless otherwise specified.)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit	
HIGH-level input voltage	V _{IH}	V _{CC} =1.2V	1.08	-	-	V	
		V _{CC} =1.65V to 1.95V	0.65×V _{CC}	-	-	V	
		V _{CC} =2.3V to 2.7V	1.7	-	-	V	
		V _{CC} =2.7V to 3.6V	2.0	-	-	V	
		V _{CC} =4.5V to 5.5V	0.7×V _{CC}	-	-	V	
LOW-level input voltage	V _{IL}	V _{CC} =1.2V	-	-	0.12	V	
		V _{CC} =1.65V to 1.95V	-	-	0.35×V _{CC}	V	
		V _{CC} =2.3V to 2.7V	-	-	0.7	V	
		V _{CC} =2.7V to 3.6V	-	-	0.8	V	
		V _{CC} =4.5V to 5.5V	-	-	0.30×V _{CC}	V	
LOW-level output voltage	V _{OL}	V _I =V _{IH} or V _{IL}	I _O =100μA; V _{CC} =1.65V to 5.5V	-	-	0.20	V
			I _O =4mA; V _{CC} =1.65V	-	-	0.45	V
			I _O =8mA; V _{CC} =2.3V	-	-	0.3	V
			I _O =12mA; V _{CC} =2.7V	-	-	0.4	V
			I _O =24mA; V _{CC} =3.0V	-	-	0.55	V
			I _O =32mA; V _{CC} =4.5V	-	-	0.55	V
input leakage current	I _I	V _I =5.5V or GND; V _{CC} =1.65V to 5.5V	-	±0.1	±5	μA	
OFF-state output current	I _{OZ}	V _I =V _{IH} ; V _O =5.5V or GND; V _{CC} =1.65V to 5.5V	-	±0.1	±10	μA	
power-off leakage current	I _{OFF}	V _I or V _O =5.5V; V _{CC} =0V	-	±0.1	±10	μA	

supply current	I_{CC}	$V_I=V_{CC}$ or GND; $I_O=0A$; $V_{CC}=5.5V$	-	0.1	10	μA
additional supply current	ΔI_{CC}	per input pin; $V_I=V_{CC}-0.6V$; $I_O=0A$; $V_{CC}=2.7V$ to 5.5V	-	5	500	μA
input capacitance	C_i	$V_{CC}=0V$ to 5.5V; $V_I=$ GND to V_{CC}	-	5.0	-	pF

Note: All typical values are measured at $V_{CC}=3.3V$ (unless stated otherwise) and $T_{amb}=25^\circ C$.

DC Characteristics 2

($T_{amb}=-40^\circ C$ to $+105^\circ C$, voltages are referenced to GND (ground=0V), unless otherwise specified.)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit	
HIGH-level input voltage	V_{IH}	$V_{CC}=1.2V$	1.08	-	-	V	
		$V_{CC}=1.65V$ to 1.95V	$0.65 \times V_{CC}$	-	-	V	
		$V_{CC}=2.3V$ to 2.7V	1.7	-	-	V	
		$V_{CC}=2.7V$ to 3.6V	2.0	-	-	V	
		$V_{CC}=4.5V$ to 5.5V	$0.7 \times V_{CC}$	-	-	V	
LOW-level input voltage	V_{IL}	$V_{CC}=1.2V$	-	-	0.12	V	
		$V_{CC}=1.65V$ to 1.95V	-	-	$0.35 \times V_{CC}$	V	
		$V_{CC}=2.3V$ to 2.7V	-	-	0.7	V	
		$V_{CC}=2.7V$ to 3.6V	-	-	0.8	V	
		$V_{CC}=4.5V$ to 5.5V	-	-	$0.30 \times V_{CC}$	V	
LOW-level output voltage	V_{OL}	$V_I=V_{IH}$ or V_{IL}	$I_O=100\mu A$; $V_{CC}=1.65V$ to 5.5V	-	-	0.30	V
			$I_O=4mA$; $V_{CC}=1.65V$	-	-	0.6	V
			$I_O=8mA$; $V_{CC}=2.3V$	-	-	0.75	V
			$I_O=12mA$; $V_{CC}=2.7V$	-	-	0.6	V
			$I_O=24mA$; $V_{CC}=3.0V$	-	-	0.8	V
			$I_O=32mA$; $V_{CC}=4.5V$	-	-	0.8	V
input leakage current	I_i	$V_I=5.5V$ or GND; $V_{CC}=1.65V$ to 5.5V	-	-	± 20	μA	
OFF-state output current	I_{OZ}	$V_I=V_{IH}$; $V_O=5.5V$ or GND; $V_{CC}=1.65V$ to 5.5V	-	-	± 20	μA	
power-off leakage current	I_{OFF}	V_I or $V_O=5.5V$; $V_{CC}=0V$	-	-	± 20	μA	
supply current	I_{CC}	$V_I=V_{CC}$ or GND; $I_O=0A$; $V_{CC}=5.5V$	-	-	40	μA	
additional supply current	ΔI_{CC}	per input pin; $V_I=V_{CC}-0.6V$; $I_O=0A$; $V_{CC}=2.7V$ to 5.5V	-	-	5000	μA	

Note: All typical values are measured at $V_{CC}=3.3V$ (unless stated otherwise) and $T_{amb}=25^\circ C$.

AC Characteristics 1

($T_{amb}=-40^\circ C$ to $+85^\circ C$, voltages are referenced to GND (ground=0V), unless otherwise specified.)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit	
nA to nY OFF-state to LOW propagation delay	t _{PZL}	see Figure 5	V _{CC} =1.2V	-	8.0	-	ns
			V _{CC} =1.65V to 1.95V	0.5	1.7	5.5	ns
			V _{CC} =2.3V to 2.7V	0.5	1.2	2.8	ns
			V _{CC} =2.7V	0.5	1.8	3.3	ns
			V _{CC} =3.0V to 3.6V	0.5	1.2	3.6	ns
			V _{CC} =4.5V to 5.5V	0.5	1.6	2.6	ns
nA to nY LOW to OFF-state propagation delay	t _{PLZ}	see Figure 5	V _{CC} =1.2V	-	10	-	ns
			V _{CC} =1.65V to 1.95V	0.5	3.0	5.5	ns
			V _{CC} =2.3V to 2.7V	0.5	1.7	2.8	ns
			V _{CC} =2.7V	0.5	2.1	3.3	ns
			V _{CC} =3.0V to 3.6V	0.5	2.5	3.6	ns
			V _{CC} =4.5V to 5.5V	0.5	1.6	2.6	ns
Power dissipation capacitance	C _{PD}	per buffer; V _I = GND to V _{CC}	V _{CC} =1.65V to 1.95V	-	6.5	-	pF
			V _{CC} =2.3V to 2.7V	-	6.9	-	pF
			V _{CC} =3.0V to 3.6V	-	7.2	-	pF

Note:

Typical values are measured at T_{amb}=25°C and V_{CC}=1.2V, 1.8V, 2.5V, 2.7V, 3.3V and 5.0V respectively.

C_{PD} is used to determine the dynamic power dissipation (P_D in uW).

$P_D = (C_{PD} \times V_{CC}^2 \times f_i \times N) + \sum (C_L \times V_{CC}^2 \times f_o)$ where:

f_i=input frequency in MHz;

f_o=output frequency in MHz;

C_L=output load capacitance in pF;

V_{CC}=supply voltage in V;

N=number of inputs switching;

$\sum (C_L \times V_{CC}^2 \times f_o)$ =sum of outputs.

AC Characteristics 2

(T_{amb}=-40°C to +105°C, voltages are referenced to GND (ground=0V), unless otherwise specified.)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit	
nA to nY OFF-state to LOW propagation delay	t _{PZL}	see Figure 5	V _{CC} =1.65V to 1.95V	0.5	-	6.5	ns
			V _{CC} =2.3V to 2.7V	0.5	-	3.5	ns
			V _{CC} =2.7V	0.5	-	4.5	ns
			V _{CC} =3.0V to 3.6V	0.5	-	4.5	ns
			V _{CC} =4.5V to 5.5V	0.5	-	3.5	ns
nA to nY LOW to OFF-state propagation delay	t _{PLZ}	see Figure 5	V _{CC} =1.65V to 1.95V	0.5	-	6.5	ns
			V _{CC} =2.3V to 2.7V	0.5	-	3.5	ns
			V _{CC} =2.7V	0.5	-	4.5	ns
			V _{CC} =3.0V to 3.6V	0.5	-	4.5	ns
			V _{CC} =4.5V to 5.5V	0.5	-	3.5	ns

Note: [1] Typical values are measured at T_{amb}=25°C and V_{CC}=1.2V, 1.8V, 2.5V, 2.7V, 3.3V and 5.0V respectively.

8. Testing Circuit

AC Testing Circuit

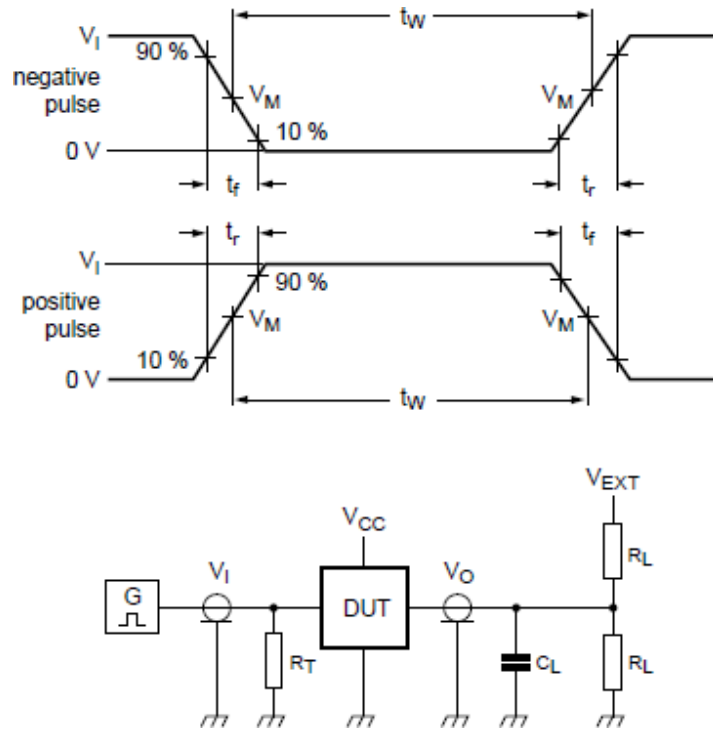


Fig. 4. Load circuitry for switching times

Definitions for test circuit:

R_L =Load resistance.

C_L =Load capacitance including jig and probe capacitance.

R_T =Termination resistance should be equal to the output impedance Z_o of the pulse generator.

V_{EXT} =External voltage for measuring switching times.

AC Testing Waveforms

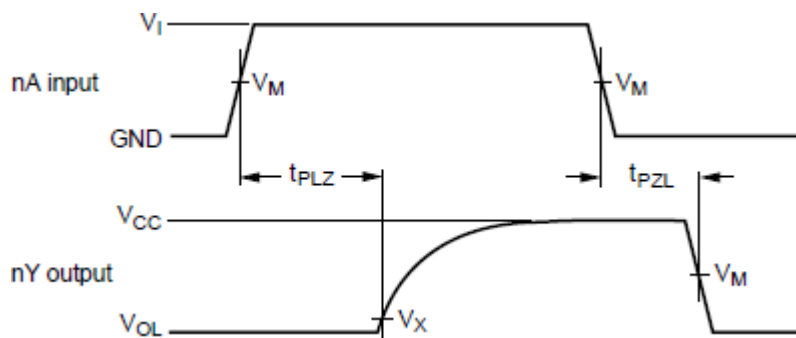


Fig. 5. The input (nA) to output (nY) propagation delays

Measurement Points

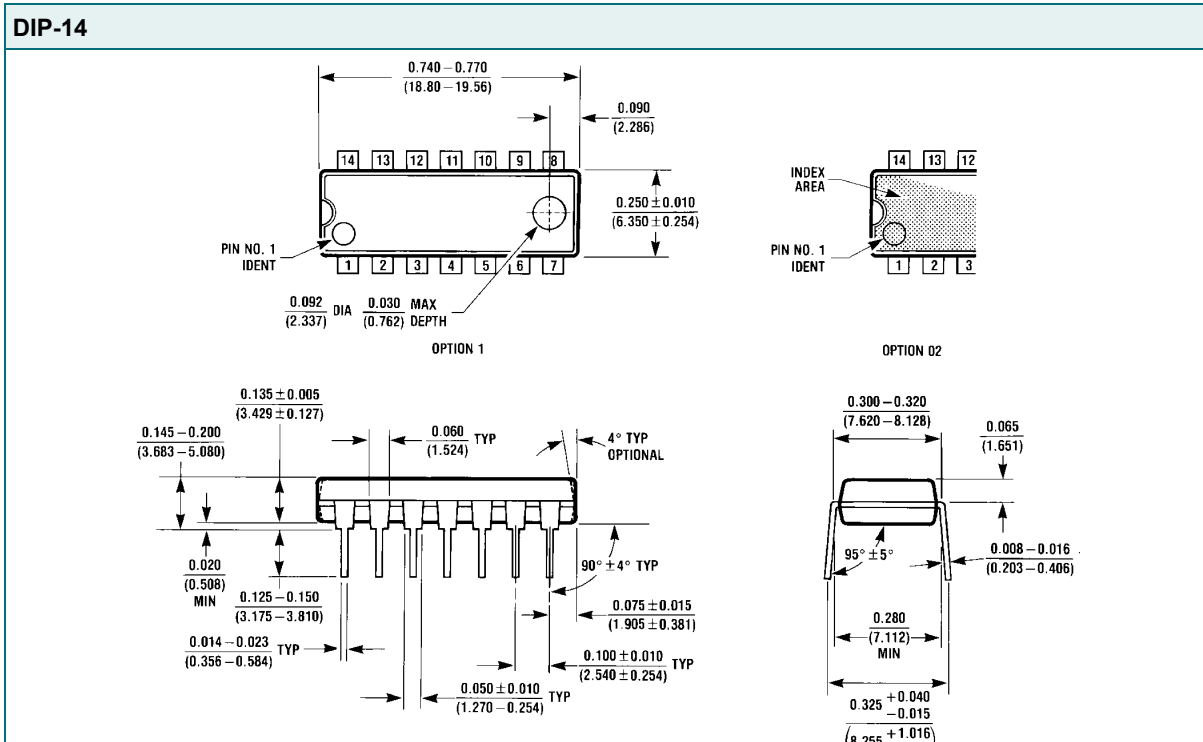
Supply voltage V_{CC}	Input V_M	Output V_X
< 2.7V	$0.5 \times V_{CC}$	$V_{OL} + 0.15V$
$\geq 2.7V$ to 3.6V	1.5V	$V_{OL} + 0.3V$
$\geq 4.5V$ to 5.5V	$0.5 \times V_{CC}$	$V_{OL} + 0.3V$

Test Data

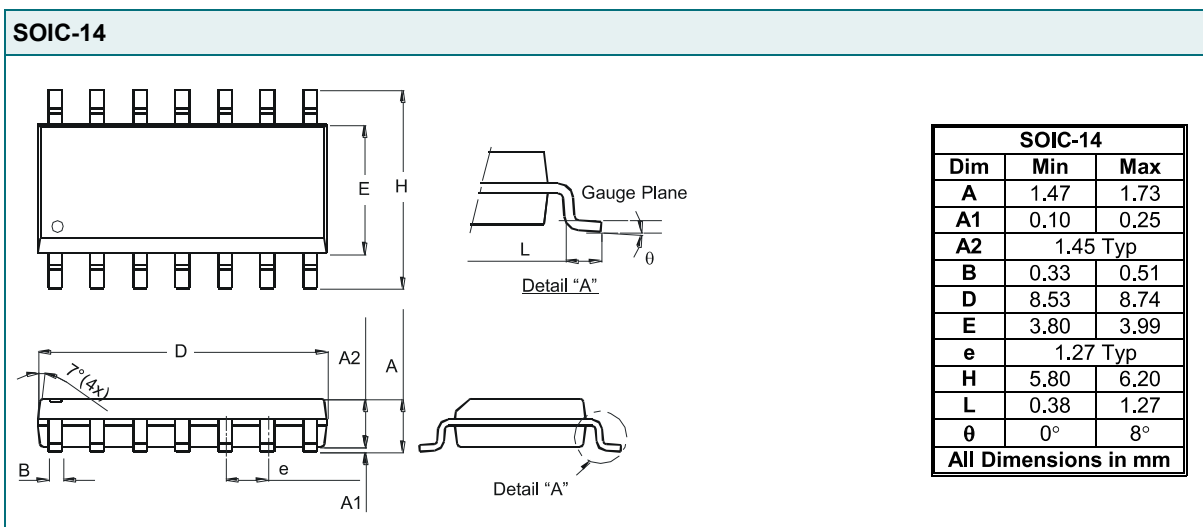
Supply voltage	Input		Load		V _{EXT}		
V _{CC}	V _I	t _r , t _f	C _L	R _L	t _{PLH} , t _{PHL}	t _{PLZ} , t _{PZL}	t _{PHZ} , t _{PZH}
1.2V	V _{CC}	≤ 2.0ns	30pF	1kΩ	open	2×V _{CC}	GND
1.65V to 1.95V	V _{CC}	≤ 2.0ns	30pF	1kΩ	open	2×V _{CC}	GND
2.3V to 2.7V	V _{CC}	≤ 2.0ns	30pF	500Ω	open	2×V _{CC}	GND
2.7V	2.7V	≤ 2.5ns	50pF	500Ω	open	2×V _{CC}	GND
3.0V to 3.6V	2.7V	≤ 2.5ns	50pF	500Ω	open	2×V _{CC}	GND
4.5V to 5.5V	V _{CC}	≤ 2.5ns	50pF	500Ω	open	2×V _{CC}	GND

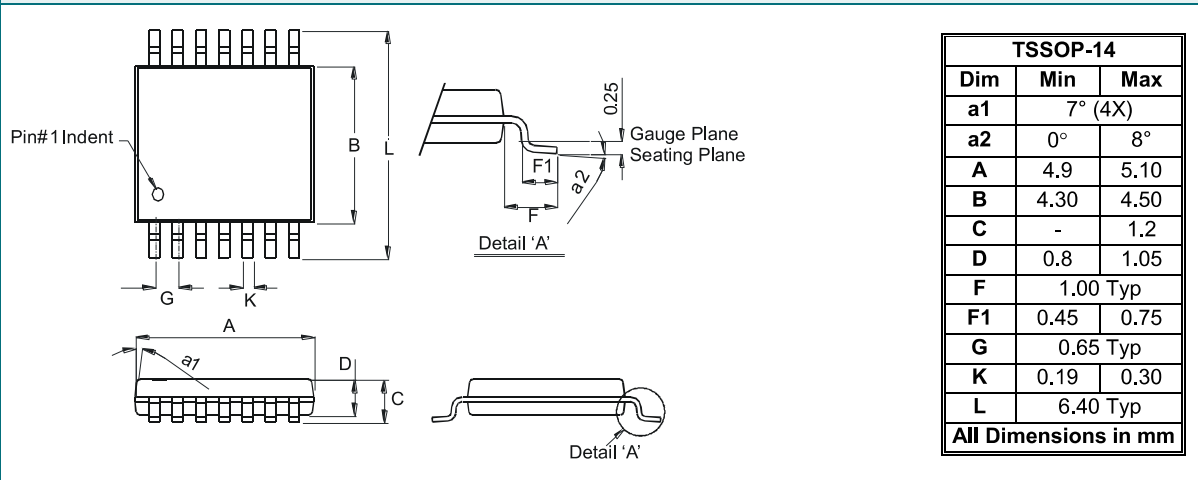
9. Package Outlines

DIP-14



SOIC-14



TSSOP-14


10. Disclaimers

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